

Notice of References Cited	Application/Control No. 10/626,177		Applicant(s)/Patent Under Reexamination WENG ET AL.	
	Examiner Nathan Danielsen		Art Unit 2627	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,493,304	12-2002	Watanabe et al.	369/53.22
*	B	US-5,974,014	10-1999	Tajiri, Takashi	369/53.13
*	C	US-4,723,234	02-1988	Katsuyama et al.	369/53.28
*	D	US-4,497,049	01-1985	d'Alayer de Costemore d'Arc, Stephane M.	369/47.11
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	N	JP 01176329 A	07-1989	Japan	KOBAYASHI et al.	
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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